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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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ATTY.	DOCKET	NO.
APV3	1645	

SERIAL NO. 10/642,518

**APPLICANT** 

Rinze BENEDICTUS et al.

FILING DATE August 18, 2003 **GROUP** 

1742

#### U.S. PATENT DOCUMENTS

EXAMINER INITIAL			DOCUM	ENT NUM	BER			DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
Sm	4	2	9	4	6	2	5	10/81	Hyatt et al.			
In	4	3	3	6	0	7	5	06/82	Quist et al.			
m	5	3	7	6_	1	9	2	12/94	Cassada, III			
· In	5	7	5	9	3	0	2_	06/98	Nakai et al.			
In	5	8	6	5 .	9	1	4	02/99	Karabin et al.			
In	5	8	7	9	4	7	5_	03/99	Karabin			
In	6	5	6	9	5	4	2	05/03	Warner et al.			
In	6	6	0	2	3	6	1_	08/03	Warner et al.			
Im	6	2	7	7	2	1	9	08/01	Heinz et al.			

### **FOREIGN PATENT DOCUMENTS**

		•	DOCUM	ENT NUM	IBER			DATE	COUNTRY	CLASS	SUBCLASS	TRANSLAT	ION
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m	1	0	2	6	2	7	0	02/02	EP	1		Abstract Only	
m	1	1	1	4	8	7	7	07/01	EP			Abstract Only	
In	0	9	8	9	1	9	5	03/00	EP			Abstract Only	
In	2004	0	1	8	7	2	3	03/04	wo				
Zm	2000		3	7	7	0	2	06/00	wo				
Jun	60	0	6	7	6	3_	6	04/85	JP			X	

# OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

US Patent Appln. Publication No. 2003/0104990 A1, to Hauer et al. (USSN 10/094,781), filed March 11, 2002, published June 5, 2003.

US Patent Appln. Publication No. 2002/0031681 A1, to Heinz et al. (USSN 09/876,233, filed June 8, 2001)

US Patent Appln. Publication No. 2002/0031681 A1, to Heinz et al. (USSN 09/876,233, filed June 8, 2001, published March 14, 2002.

EXAMINER

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DATE CONSIDERED

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EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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EXAMINER INITIAL		DOCUM	ENT NUM	BER_		DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

## **FOREIGN PATENT DOCUMENTS**

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Jm	60	2	5_	1	2	6	0	12-85	JP			х	<u> </u>
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fin		4	8	9	4	0	8	6-92	EP			Х	
Jm	1	0	4	5	0	4	3	10/02	EP			Abstract only	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

m/	US Patent Appln. Publication No. 2004/0060618 A1, to Benedictus et al. (USSN 10/639,776), filed August 13, 2003, published April 1, 2004.
Jm	US Patent Appln. Publication No. 2003/0070734 A1, to Heinz et al. (USSN 10/195,483, filed July 16, 2002, published April 17, 2003.
Jm	Davis, J.R., "ASM Specialty Handbook - Aluminium and Aluminium Alloys", ASM International, p 63-64 (1993).
yn	Davis, J.R., "ASM Specialty Handbook - Aluminium and Aluminium Alloys", ASM International, Paper No. XP-002266795, p. 20 (1996).
Jn	N. Ridlev and J. Pilling, "Superplastic deformation characteristics of some commercial aluminium alloys", Aluminium Technology, London, Book 3, Session B, Pgs. 44.1-44.7 (March, 1986)
Jun	Davis, J.R., ASM Specialty Handbook, "Aluminium-Lithium Alloys", pg. 121 (May, 1994)
Jom	Davis, J.R., ASM Specialty Handbook, "Aluminium and Aluminium Alloys", pgs. 143-147 (1993)
Jin	"ASM Handbook: Vol. 2 Properties and Selection: Nonferrous Alloys and Special-Purpose Materials", ASM International, pgs. 70-79 (1990)
Jm	"ASM Handbook: Vol. 9 Metallography and Microstructures", ASM International, pgs. 364-365 (1985)

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DATE CONSIDERED

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The office actions above have been (Form PTO-1449 [6-4]) considered by the examinor but are crossed off as they will not be printed in the references cited scetion.

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